



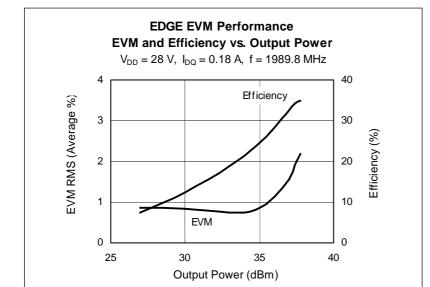
LDMOS RF Power Field Effect Transistor 10 W, 1805 – 1880 MHz, 1930 – 1990 MHz 10 W, 2110 – 2170 MHz

Description

The PTF180101S is a 10-watt, internally-matched *GOLDMOS*® FET device intended for EDGE applications in the DCS/PCS band. Full gold metallization ensures excellent device lifetime and reliability.

PTF180101S Package H-32259-2





Features

- RoHS-compliant, Pb-free package
- Typical EDGE performance
 - Average output power = 4.0 W
 - Gain = 19.0 dB
 - Efficiency = 28%
 - EVM = 1.1 %
- Typical WCDMA performance
 - Average output power = 1.8 W
 - Gain = 18.0 dB
 - Efficiency = 20%
 - ACPR = -45 dBc
- Typical CW performance
 - Output power at P-1dB = 15 W
 - Efficiency = 50%
- Integrated ESD protection: Human Body Model Class 1 (minimum)
- · Low HCl drift, excellent thermal stability
- Capable of handling 10:1 VSWR @ 28 V, 10 W (CW) output power

RF Characteristics, EDGE Operation

EDGE Measurements (not subject to production test—verified by design/characterization in Infineon test fixture) $V_{DD} = 28 \text{ V}$, $I_{DO} = 180 \text{ mA}$, $P_{OUT} = 4 \text{ W}$, f = 1989.8 MHz

Characteristic	Symbol	Min	Тур	Max	Unit
Error Vector Magnitude	EVM (RMS)	_	1.1	_	%
Modulation Spectrum @ 400 kHz	ACPR	_	-60	_	dBc
Modulation Spectrum @ 600 kHz	ACPR	_	-70	_	dBc
Gain	G _{ps}	_	19	_	dB
Drain Efficiency	η_{D}	_	28	_	%

table continued on next page

All published data at $T_{CASE} = 25^{\circ}C$ unless otherwise indicated

ESD: Electrostatic discharge sensitive device—observe handling precautions!



RF Characteristics, EDGE Operation (cont.)

Two-tone Measurements (tested in Infineon test fixture)

 V_{DD} = 28 V, I_{DQ} = 180 mA, P_{OUT} = 10 W PEP, f = 1990 MHz, tone spacing = 1 MHz

Characteristic	Symbol	Min	Тур	Max	Unit
Gain	G_{ps}	18	19	_	dB
Drain Efficiency	η_{D}	30	33	_	%
Intermodulation Distortion	IMD	_	-30	-28	dBc

RF Characteristics, WCDMA Operation

WCDMA Measurements (not subject to production test—verified by design/characterization in Infineon test fixture) $V_{DD} = 28 \text{ V}$, $I_{DQ} = 135 \text{ mA}$, $P_{OUT} = 1.8 \text{ W}$,

f = 2170 MHz, 3GPP signal, channel bandwidth = 3.84 MHz, peak/average = 8.7 dB @ 0.01% CCDF

Characteristic	Symbol	Min	Тур	Max	Unit
Adjacent Channel Power Ratio	ACPR	_	-45	_	dBc
Gain	G _{ps}	_	18	_	dB
Drain Efficiency	η_{D}	_	20	_	%

Two-tone Measurements (not subject to production test—verified by design/characterization in Infineon test fixture) $V_{DD} = 28 \text{ V}$, $I_{DQ} = 135 \text{ mA}$, $P_{OUT} = 10 \text{ W PEP}$, f = 2170 MHz, tone spacing = 1 MHz

Characteristic	Symbol	Min	Тур	Max	Unit
Gain	G _{ps}	_	18	_	dB
Drain Efficiency @ -30 dBc IM3	η_{D}	_	37	_	%
Intermodulation Distortion	IMD	_	-30	_	dBc

DC Characteristincs

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{DS} = 10 \mu\text{A}$	V _{(BR)DSS}	65	_	_	V
Drain Leakage Current	V _{DS} = 28 V, V _{GS} = 0 V	I _{DSS}	_	_	1.0	μΑ
On-State Resistance	V _{GS} = 10 V, V _{DS} = 0.1 A	R _{DS(on)}	_	0.83	_	Ω
Operating Gate Voltage	V _{DS} = 28 V, I _{DQ} = 180 mA	V _{GS}	2.5	3.2	4.0	V
Gate Leakage Current	V _{GS} = 10 V, V _{DS} = 0 V	I _{GSS}	_	_	1.0	μΑ

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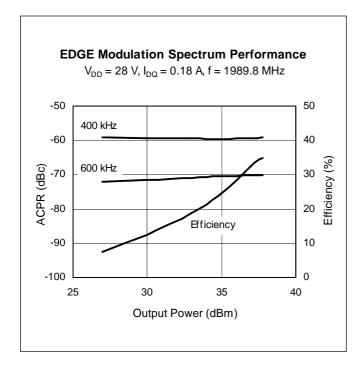
Maximum Ratings

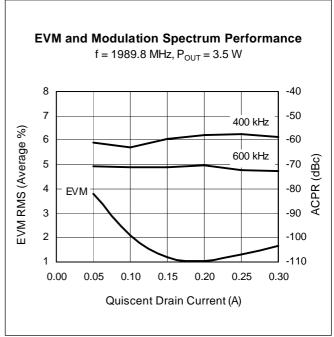
Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	65	V
Gate-Source Voltage	V _{GS}	-0.5 to +12	V
Junction Temperature	TJ	200	°C
Total Device Dissipation	P _D	58	W
Above 25°C derate by		0.333	W/°C
Storage Temperature Range	T _{STG}	-40 to +150	°C
Thermal Resistance (T _{CASE} = 70°C, 10 W CW)	$R_{ heta JC}$	3.0	°C/W

Ordering Information

Туре	Package Outline	Package Description	Marking
PTF180101S	H-32259-2	Thermally enhanced, surface mount	PTF180101S

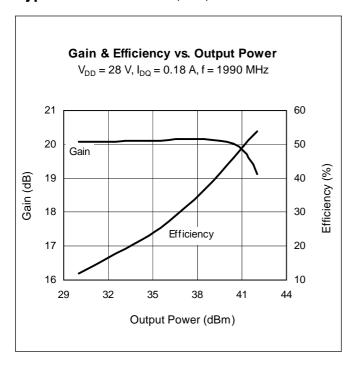
Typical Performance measurements taken in broadband test fixture

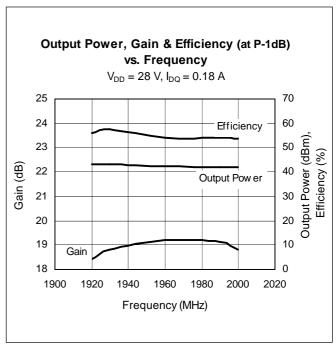


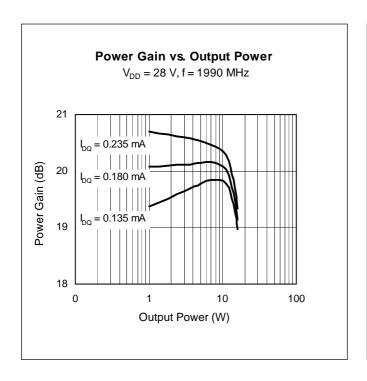


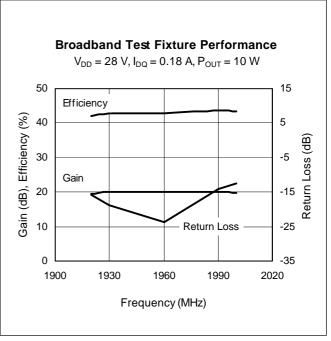


Typical Performance (cont.)



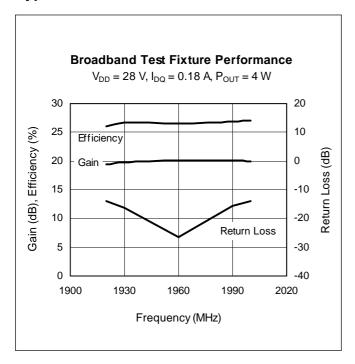


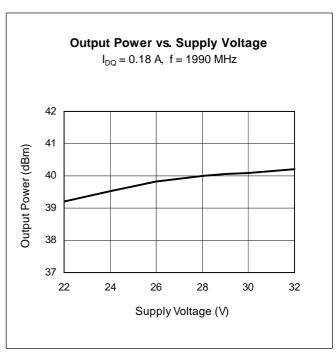


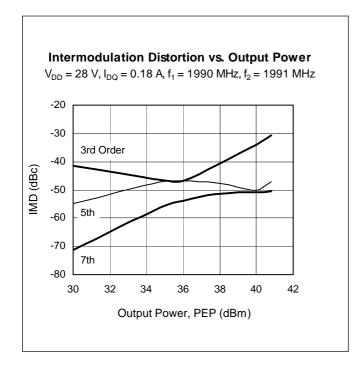


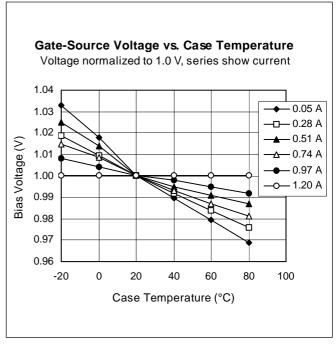


Typical Performance (cont.)



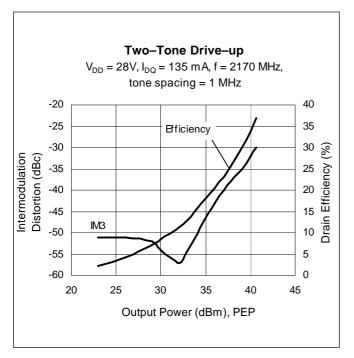


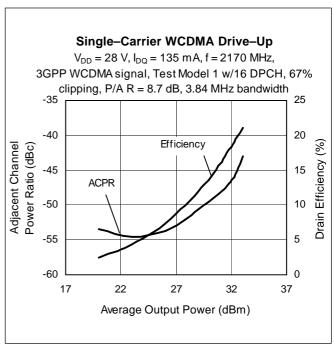




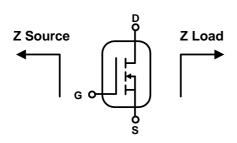


Typical Performance, WCDMA Operation

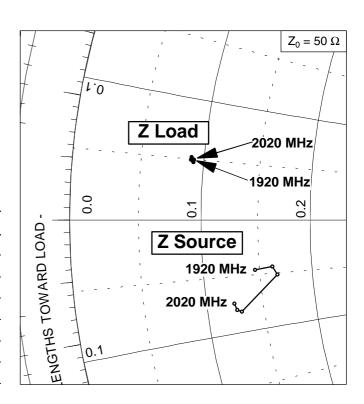




Broadband Circuit Impedance Data

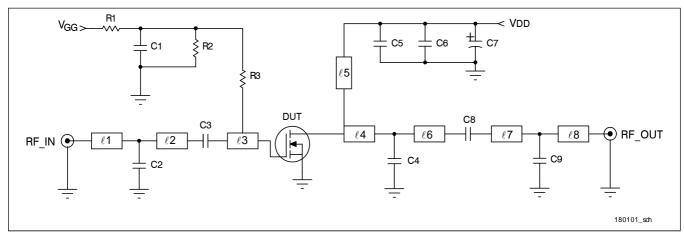


Frequency	Z Sou	Z Source W		oad W
MHz	R	jΧ	R	jΧ
1920	7.3	-2.3	4.6	2.4
1930	8.1	-2.2	4.6	2.5
1960	8.3	-2.6	4.5	2.6
1990	6.5	-4.1	4.5	2.5
2000	6.3	-4.0	4.5	2.5
2020	6.2	-3.7	4.6	2.5





Reference Circuits



Reference circuit schematic for 1990 MHz

Circuit Assembly Information

DUT	PTF180101S	LDMOS Transistor	
PCB	0.76 mm [.030"] thick, $\varepsilon_{r} = 4.5$	Rogers TMM4, 2 oz. Copper	

Microstrip	Electrical Characteristics at 1990 MHz ¹	Dimensions: L x W (mm)	Dimensions: L x W (in.)
<i>ℓ</i> 1	0.133 λ, 50 Ω	10.92 x 1.37	0.430 x 0.054
ℓ2	0.096 λ, 50 Ω	7.87 x 1.37	0.310 x 0.054
<i>ℓ</i> 3	0.155 λ, 9.5 Ω	11.30 x 12.45	0.445 x 0.490
ℓ4	0.008 λ, 12.8 Ω	0.64 x 8.86	0.025 x 0.349
<i>ℓ</i> 5	0.286 λ, 70 Ω	23.88 x 0.71	0.940 x 0.028
<i>ℓ</i> 6	0.247 λ, 12.8 Ω	18.29 x 8.86	0.720 x 0.349
ℓ7	0.145 λ, 50 Ω	11.81 x 1.37	0.465 x 0.054
<i>ℓ</i> 8	0.008 λ, 50 Ω	0.64 x 1.37	0.025 x 0.054

¹Electrical characteristics are rounded.



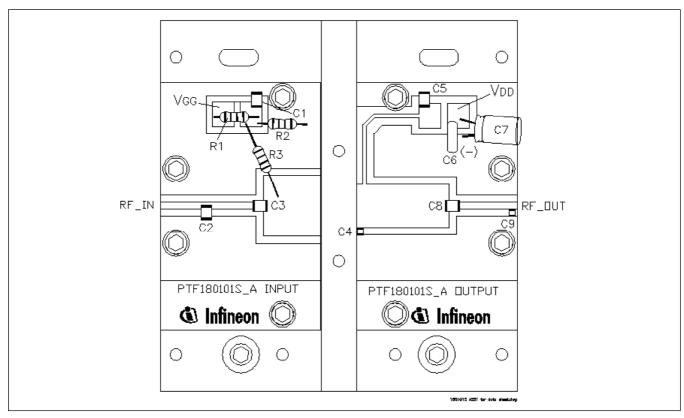
Reference Circuits (cont.)

1930 - 1990 MHz Operation

Component	Description	Suggested Manufacturer	P/N or Comment
C1, C3, C5, C8	Capacitor, 10 pF	ATC	100B 100
C2	Capacitor, 1.7 pF	ATC	100B 1R7
C4	Capacitor, 2.0 pF	ATC	100A 2R0
C6	Capacitor, 0.1 μF, 50 V	Digi-Key	P4525-ND
C7	Capacitor, 100 μF, 50 V	Digi-Key	P5182-ND
C9	Capacitor, 0.6 pF	ATC	100A 0R6
R1, R2, R3	Resistor, 220 ohm, 1/4 W	Digi-Key	220QBK

2.11 - 2.17 GHz Operation

Component	Description	Suggested Manufacturer	P/N or Comment
C1, C3, C5, C8	Capacitor, 10 pF	ATC	100B 100
C2	Capacitor, 0.8 pF	ATC	100B 0R8
C4	Capacitor, 2.2 pF	ATC	100A 2R2
C6	Capacitor, 0.1 μF, 50 V	Digi-Key	P4525-ND
C7	Capacitor, 100 µF, 50 V	Digi-Key	P5182-ND
C9	Capacitor, 1.0 pF	ATC	100A 1R0
R1, R2, R3	Resistor, 220 ohm, 1/4 W	Digi-Key	220QBK

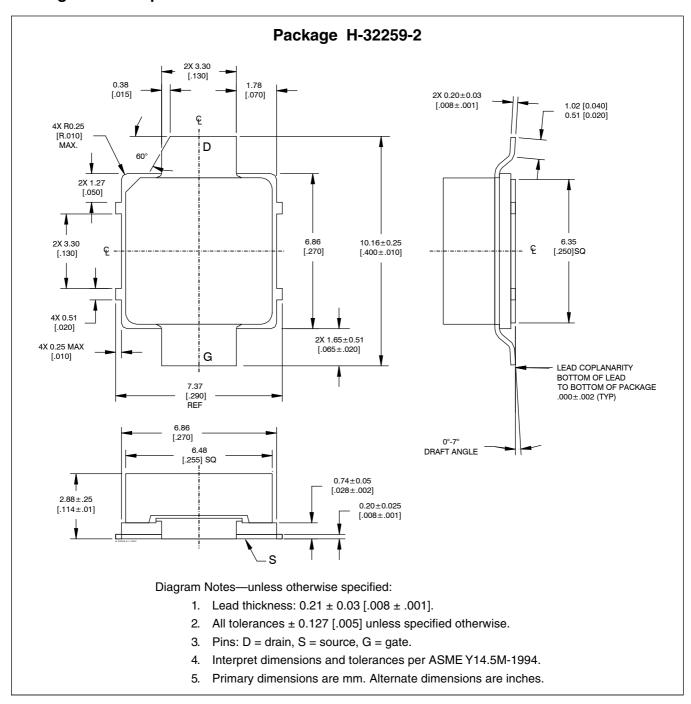


Reference circuit assembly diagram* (not to scale)

^{*}Gerber files for this circuit are available upon request.



Package Outline Specifications



Find the latest and most complete information about products and packaging at the Infineon Internet page http://www.infineon.com/products

	ial, Limited Internal Distribution	D O
Revision	History: 2007-03-01	Data Sheet
Previous '	Version: 2004-02-03	
Page	Subjects (major changes since last revision)	
all	Update document format	
1	Add RoHS-compliant information.	
9	Correct package diagram and dimensions.	

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